

## Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination REIF ET AL.

Examiner

Paul A. Zucker

Applicant(s)/Patent Under Reexamination REIF ET AL.

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-4,193,932	03-1980	Yamamoto et al		
	В	US-				
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	D	US-				
	Е	US-				
	F	US-				
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## **NON-PATENT DOCUMENTS**

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